

Preliminary datasheet

EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC

Features

- Electrical features
 - $V_{DS} = 1200\text{ V}$
 - $I_{DN} = 50\text{ A}$ / $I_{DRM} = 100\text{ A}$
 - Low inductive design
 - High current density
- Mechanical features
 - Integrated NTC temperature sensor
 - PressFIT contact technology
 - Rugged mounting due to integrated mounting clamps



Typical appearance

Potential applications

- Solar applications

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description

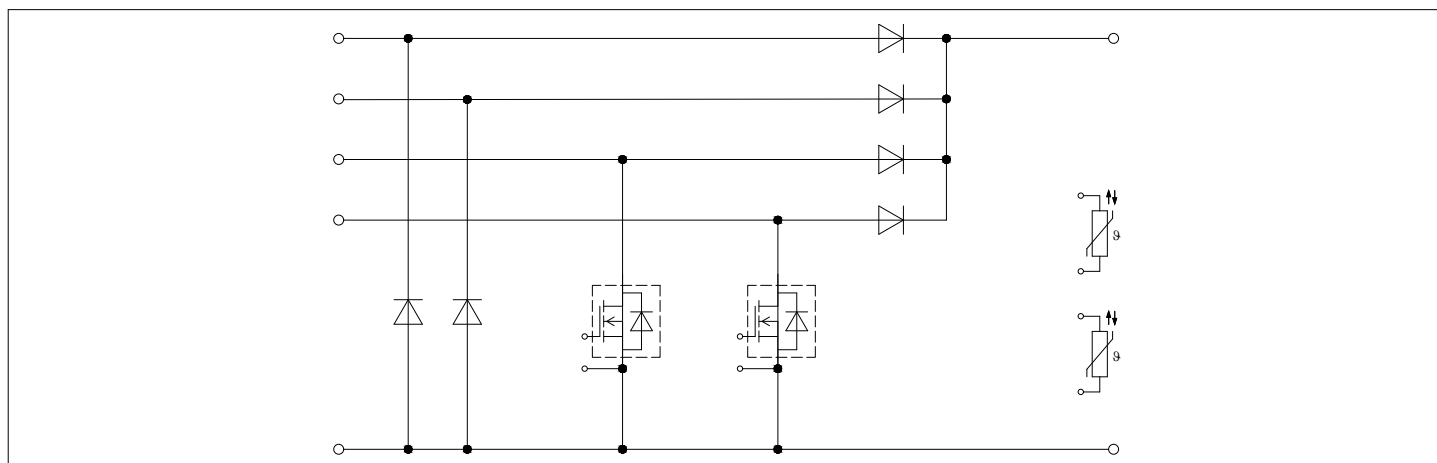


Table of contents

	Description	1
	Features	1
	Potential applications	1
	Product validation	1
	Table of contents	2
1	Package	3
2	MOSFET	3
3	Body diode	5
4	Diode, Boost	6
5	Bypass-diode	6
6	Inverse-polarity protection diode	7
7	NTC-Thermistor	8
8	Characteristics diagrams	9
9	Circuit diagram	16
10	Package outlines	17
11	Module label code	18
	Revision history	19
	Disclaimer	20

1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al_2O_3	
Comparative tracking index	CTI		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{sCE}			10		nH
Module lead resistance, terminals - chip	$R_{AA'+CC'}$	$T_H = 25 \text{ °C}$, per switch		3		mΩ
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25 \text{ °C}$, per switch		2		mΩ
Storage temperature	T_{stg}		-40		125	°C
Mounting force per clamp	F		20		50	N
Weight	G			24		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}		$T_{vj} = 25 \text{ °C}$	1200	V
Implemented drain current	I_{DN}			50	A
Continuous DC drain current	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$	$T_H = 65 \text{ °C}$	45	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}		100	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$		-10/23	V
Gate-source voltage, max. static voltage	V_{GS}			-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 50\text{ A}$		$V_{GS} = 18\text{ V}, T_{vj} = 25\text{ °C}$	16.2	mΩ
				$V_{GS} = 18\text{ V}, T_{vj} = 125\text{ °C}$	26.1	
				$V_{GS} = 18\text{ V}, T_{vj} = 175\text{ °C}$	34.7	
				$V_{GS} = 15\text{ V}, T_{vj} = 25\text{ °C}$	19.4	
Gate threshold voltage	$V_{GS(th)}$	$I_D = 20\text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25\text{ °C},$ (tested after 1ms pulse at $V_{GS} = +20\text{ V}$)	3.45	4.3	5.15	V
Total gate charge	Q_G	$V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}$		0.149		μC
Internal gate resistor	R_{Gint}	$T_{vj} = 25\text{ °C}$		4.1		Ω
Input capacitance	C_{ISS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}, T_{vj} = 25\text{ °C}$		4.4		nF
Output capacitance	C_{OSS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}, T_{vj} = 25\text{ °C}$		0.21		nF
Reverse transfer capacitance	C_{RSS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}, T_{vj} = 25\text{ °C}$		0.014		nF
C_{OSS} stored energy	E_{OSS}	$V_{DS} = 800\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$		86		μJ
Drain-source leakage current	I_{DSS}	$V_{DS} = 1200\text{ V}, V_{GS} = -3\text{ V}, T_{vj} = 25\text{ °C}$		0.03	210	μA
Gate-source leakage current	I_{GSS}	$V_{DS} = 0\text{ V}, T_{vj} = 25\text{ °C}$			400	nA
Turn-on delay time (inductive load)	$t_{d on}$	$I_D = 50\text{ A}, R_{Gon} = 3.3\text{ Ω}, V_{DD} = 600\text{ V}, V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	32		ns
			$T_{vj} = 125\text{ °C}$	32		
			$T_{vj} = 175\text{ °C}$	32		
Rise time (inductive load)	t_r	$I_D = 50\text{ A}, R_{Gon} = 3.3\text{ Ω}, V_{DD} = 600\text{ V}, V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	23.9		ns
			$T_{vj} = 125\text{ °C}$	23.9		
			$T_{vj} = 175\text{ °C}$	23.9		

(table continues...)

Table 5 (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 50\ A, R_{Goff} = 2\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	60.7		ns
			$T_{vj} = 125\ ^\circ C$	60.7		
			$T_{vj} = 175\ ^\circ C$	60.7		
Fall time (inductive load)	t_f	$I_D = 50\ A, R_{Goff} = 2\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	10.5		ns
			$T_{vj} = 125\ ^\circ C$	10.5		
			$T_{vj} = 175\ ^\circ C$	10.5		
Turn-on energy loss per pulse	E_{on}	$I_D = 50\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Gon} = 3.3\ \Omega, di/dt = 4.29\ kA/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.516		mJ
			$T_{vj} = 125\ ^\circ C$	0.516		
			$T_{vj} = 175\ ^\circ C$	0.516		
Turn-off energy loss per pulse	E_{off}	$I_D = 50\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Goff} = 2\ \Omega, dv/dt = 45.7\ kV/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.133		mJ
			$T_{vj} = 125\ ^\circ C$	0.133		
			$T_{vj} = 175\ ^\circ C$	0.133		
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET		1.1		K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		175	$^\circ C$

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj,op} > 150^\circ C$ is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

3 Body diode

Table 6 **Maximum rated values**

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V$	$T_H = 65\ ^\circ C$	24	A

Table 7 **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 50\ A, V_{GS} = -3\ V$	$T_{vj} = 25\ ^\circ C$	4.2	5.35	V
			$T_{vj} = 125\ ^\circ C$	3.9		
			$T_{vj} = 175\ ^\circ C$	3.8		

4 Diode, Boost

Table 8 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Repetitive peak reverse voltage	V_{RRM}		$T_{vj} = 25\text{ °C}$	1200	V
Continuous DC forward current	I_F			40	A
Repetitive peak forward current	I_{FRM}	$t_P = 1\text{ ms}$		80	A
I^2t - value	I^2t	$t_P = 10\text{ ms}, V_R = 0\text{ V}$	$T_{vj} = 125\text{ °C}$	320	A^2s
			$T_{vj} = 150\text{ °C}$	295	

Table 9 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_F	$I_F = 40\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$	1.40	1.85	V
			$T_{vj} = 125\text{ °C}$	1.70		
			$T_{vj} = 150\text{ °C}$	1.85		
Peak reverse recovery current	I_{RM}	$V_{CC} = 600\text{ V}, I_F = 40\text{ A}, -di_F/dt = 3900\text{ A}/\mu s$ ($T_{vj} = 150\text{ °C}$)	$T_{vj} = 25\text{ °C}$	43		A
			$T_{vj} = 125\text{ °C}$	43		
			$T_{vj} = 150\text{ °C}$	43		
Recovered charge	Q_r	$V_{CC} = 600\text{ V}, I_F = 40\text{ A}, -di_F/dt = 3900\text{ A}/\mu s$ ($T_{vj} = 150\text{ °C}$)	$T_{vj} = 25\text{ °C}$	4.03		μC
			$T_{vj} = 125\text{ °C}$	4.03		
			$T_{vj} = 150\text{ °C}$	4.03		
Reverse recovery energy	E_{rec}	$V_{CC} = 600\text{ V}, I_F = 40\text{ A}, -di_F/dt = 3900\text{ A}/\mu s$ ($T_{vj} = 150\text{ °C}$)	$T_{vj} = 25\text{ °C}$	0.063		mJ
			$T_{vj} = 125\text{ °C}$	0.063		
			$T_{vj} = 150\text{ °C}$	0.063		
Thermal resistance, junction to heat sink	R_{thJH}	per diode		1.11		K/W
Temperature under switching conditions	$T_{vj\text{ op}}$			-40	150	°C

5 Bypass-diode

Table 10 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Repetitive peak reverse voltage	V_{RRM}		$T_{vj} = 25\text{ °C}$	1200	V

(table continues...)

Table 10 (continued) Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Maximum RMS forward current per chip	I_{FRMSM}	$T_H = 80\text{ °C}$		50	A
Maximum RMS current at rectifier output	I_{RMSM}	$T_H = 80\text{ °C}$		50	A
Surge forward current	I_{FSM}	$t_P = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	450	A
			$T_{vj} = 150\text{ °C}$	360	
I^2t - value	I^2t	$t_P = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	1010	A^2s
			$T_{vj} = 150\text{ °C}$	648	

Table 11 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Forward voltage	V_F	$I_F = 30\text{ A}$	$T_{vj} = 150\text{ °C}$		0.95		V
Reverse current	I_r	$T_{vj} = 150\text{ °C}, V_R = 1200\text{ V}$			0.1		mA
Thermal resistance, junction to heat sink	R_{thJH}	per diode			1.29		K/W
Temperature under switching conditions	$T_{vj, op}$			-40		150	°C

6 Inverse-polarity protection diode

Table 12 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Repetitive peak reverse voltage	V_{RRM}		$T_{vj} = 25\text{ °C}$	1200	V
Maximum RMS forward current per chip	I_{FRMSM}	$T_H = 80\text{ °C}$		50	A
Maximum RMS current at rectifier output	I_{RMSM}	$T_H = 80\text{ °C}$		50	A
Surge forward current	I_{FSM}	$t_P = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	450	A
			$T_{vj} = 150\text{ °C}$	360	
I^2t - value	I^2t	$t_P = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	1010	A^2s
			$T_{vj} = 150\text{ °C}$	648	

Table 13 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Forward voltage	V_F	$I_F = 30 \text{ A}$	$T_{vj} = 150 \text{ °C}$		0.95		V
Reverse current	I_r	$T_{vj} = 150 \text{ °C}, V_R = 1200 \text{ V}$			0.1		mA
Thermal resistance, junction to heat sink	R_{thJH}	per diode			1.16		K/W
Temperature under switching conditions	$T_{vj, op}$			-40		150	°C

7 NTC-Thermistor

Table 14 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25 \text{ °C}$			5		kΩ
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100 \text{ °C}, R_{100} = 493 \text{ Ω}$		-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25 \text{ °C}$				20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$			3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$			3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$			3433		K

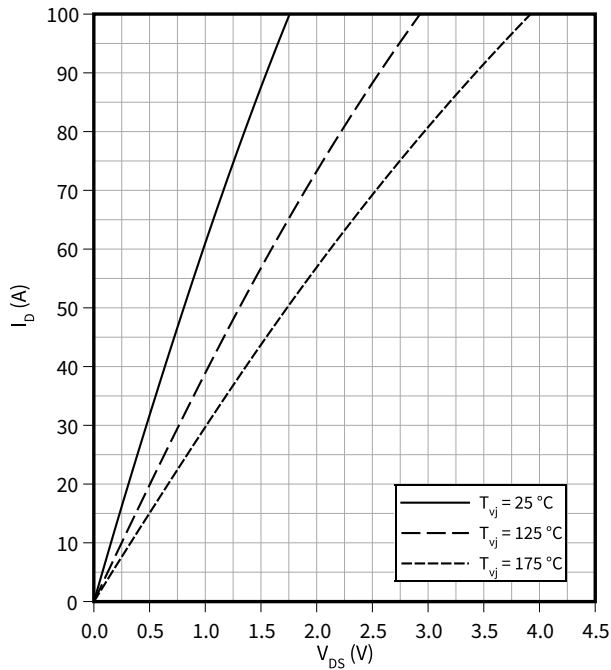
Note: Specification according to the valid application note.

8 Characteristics diagrams

Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$

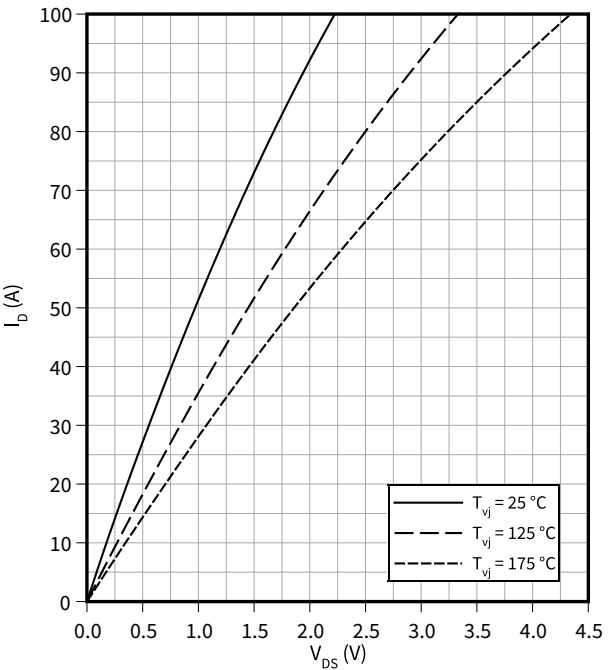
$V_{GS} = 18\text{ V}$



Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$

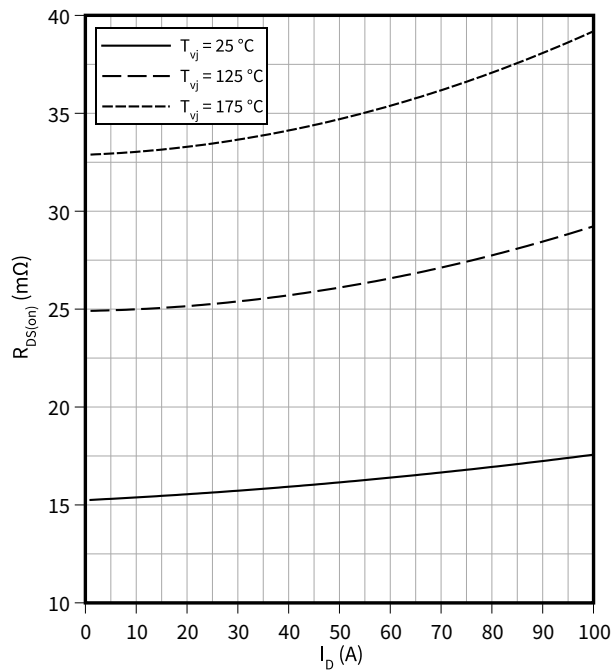
$V_{GS} = 15\text{ V}$



Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(I_D)$

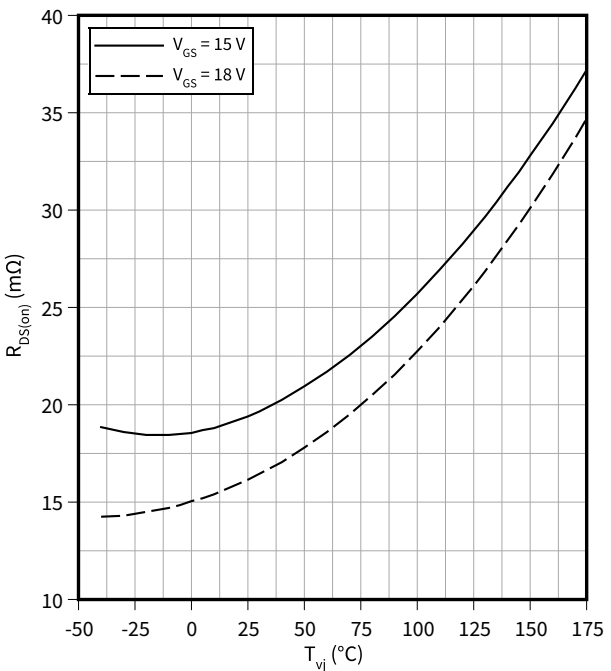
$V_{GS} = 18\text{ V}$



Drain source on-resistance (typical), MOSFET

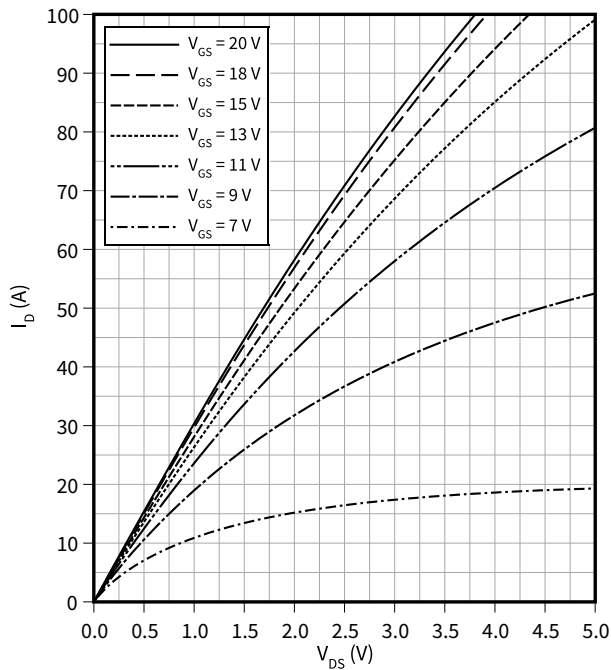
$R_{DS(on)} = f(T_{vj})$

$I_D = 50\text{ A}$



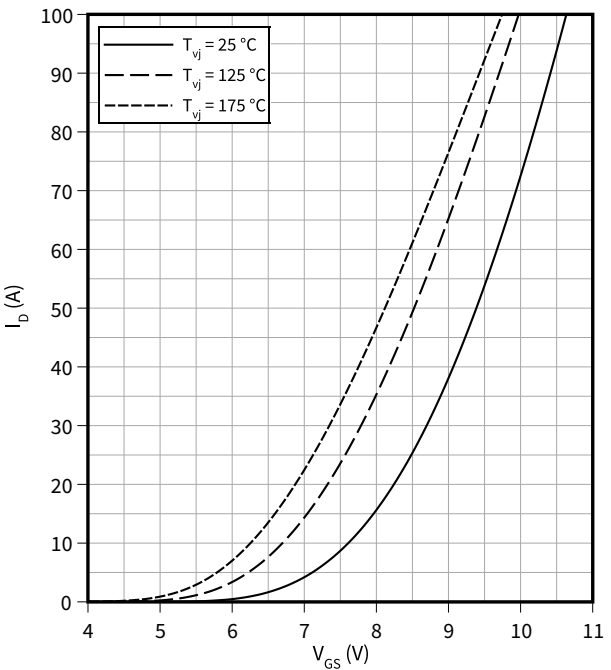
Output characteristic field (typical), MOSFET

$I_D = f(V_{DS})$
 $T_{vj} = 175\text{ °C}$



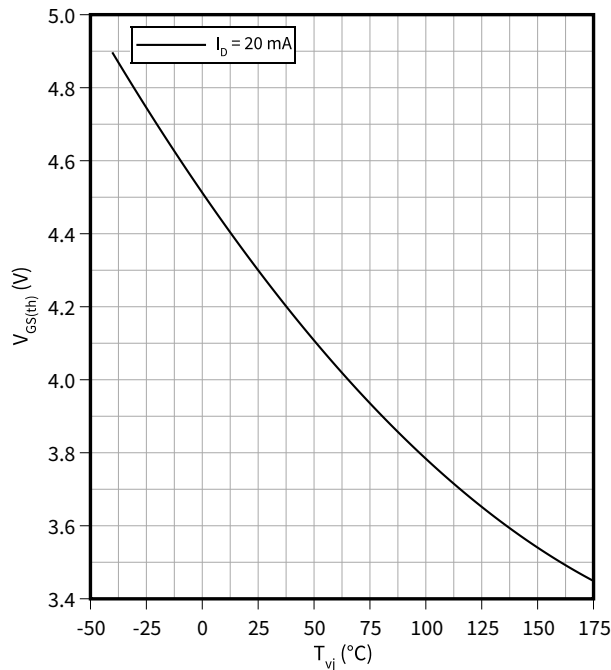
Transfer characteristic (typical), MOSFET

$I_D = f(V_{GS})$
 $V_{DS} = 20\text{ V}$



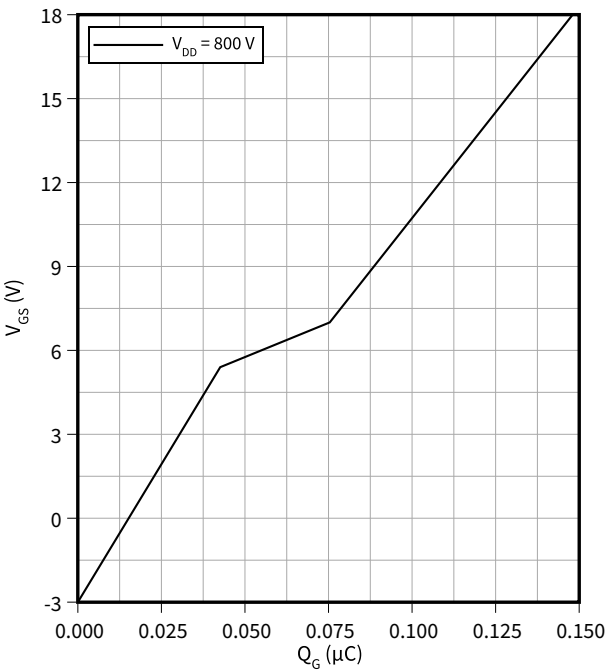
Gate-source threshold voltage (typical), MOSFET

$V_{GS(th)} = f(T_{vj})$
 $V_{GS} = V_{DS}$



Gate charge characteristic (typical), MOSFET

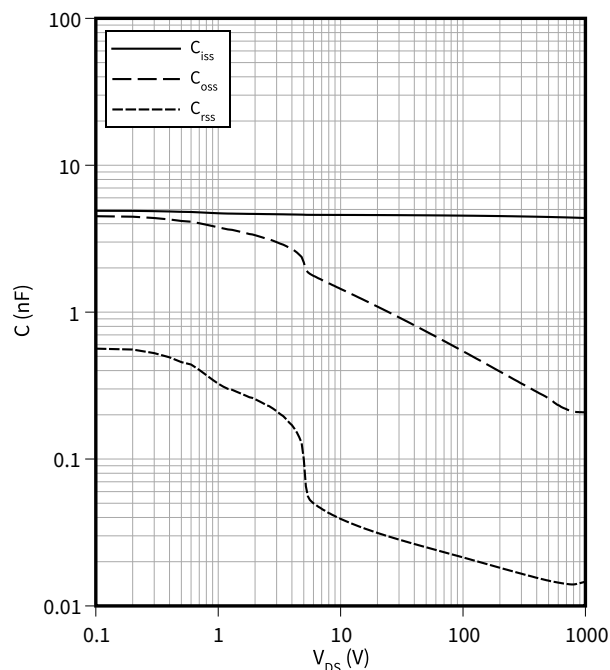
$V_{GS} = f(Q_G)$
 $I_D = 50\text{ A}, T_{vj} = 25\text{ °C}$



Capacity characteristic (typical), MOSFET

$$C = f(V_{DS})$$

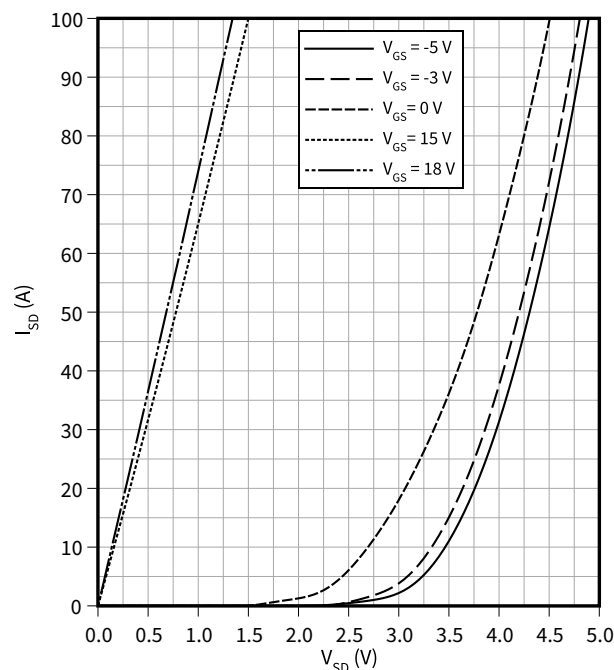
$f = 100 \text{ kHz}$, $T_{vj} = 25 \text{ °C}$, $V_{GS} = 0 \text{ V}$



Forward characteristic body diode (typical), MOSFET

$$I_{SD} = f(V_{SD})$$

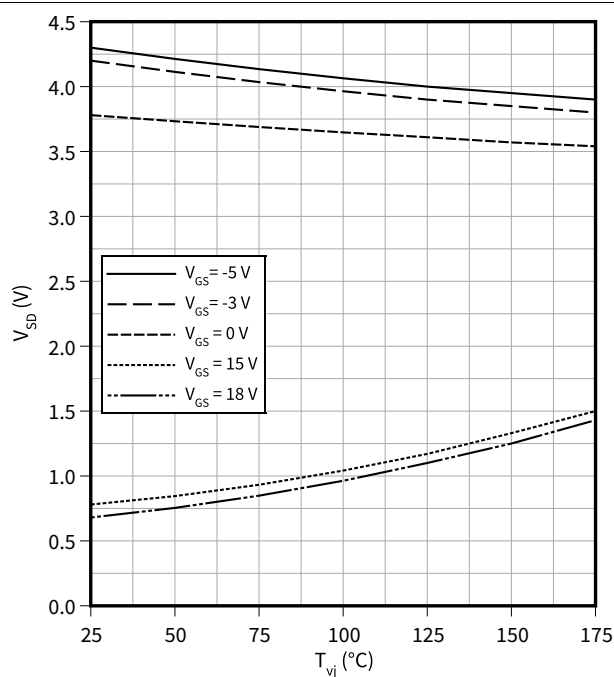
$T_{vj} = 25 \text{ °C}$



Forward characteristic body diode (typical), MOSFET

$$V_{SD} = f(T_{vj})$$

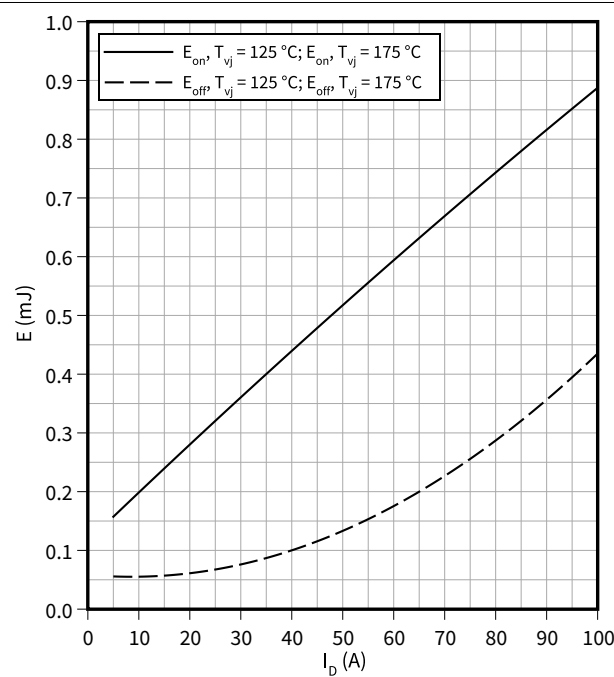
$I_{SD} = 50 \text{ A}$



Switching losses (typical), MOSFET

$$E = f(I_D)$$

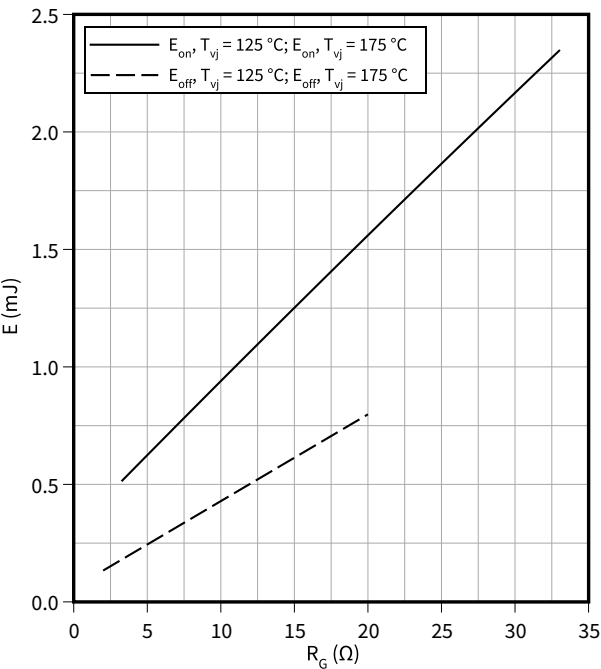
$R_{Goff} = 2 \text{ } \Omega$, $R_{Gon} = 3.3 \text{ } \Omega$, $V_{DD} = 600 \text{ V}$, $V_{GS} = -3/18 \text{ V}$



8 Characteristics diagrams

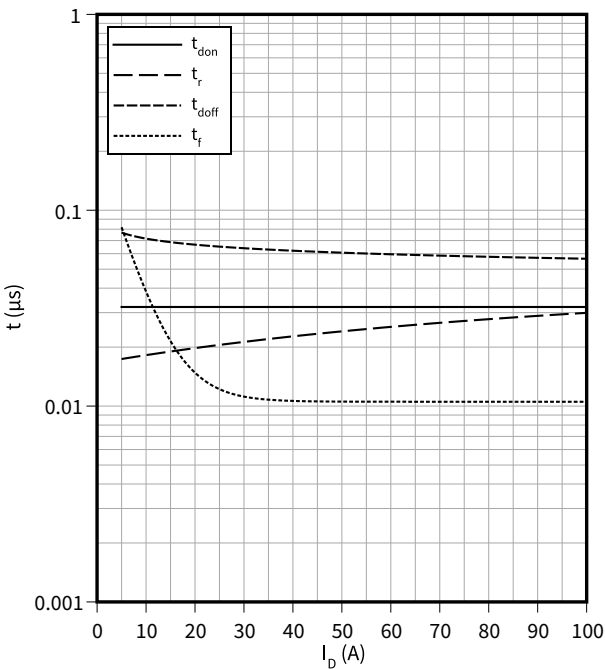
Switching losses (typical), MOSFET

$E = f(R_G)$
 $V_{DD} = 600\text{ V}$, $I_D = 50\text{ A}$, $V_{GS} = -3/18\text{ V}$



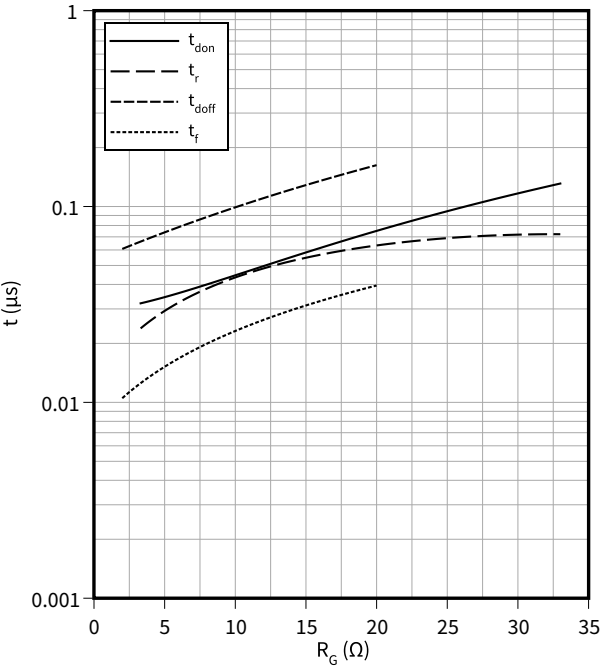
Switching times (typical), MOSFET

$t = f(I_D)$
 $R_{Goff} = 2\text{ }\Omega$, $R_{Gon} = 3.3\text{ }\Omega$, $V_{DD} = 600\text{ V}$, $T_{vj} = 175\text{ }^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



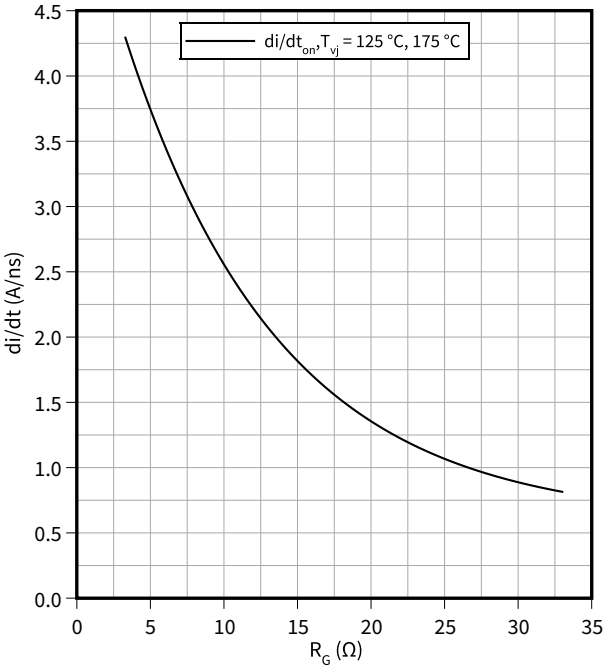
Switching times (typical), MOSFET

$t = f(R_G)$
 $V_{DD} = 600\text{ V}$, $I_D = 50\text{ A}$, $T_{vj} = 175\text{ }^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



Current slope (typical), MOSFET

$di/dt = f(R_G)$
 $V_{DD} = 600\text{ V}$, $I_D = 50\text{ A}$, $V_{GS} = -3/18\text{ V}$

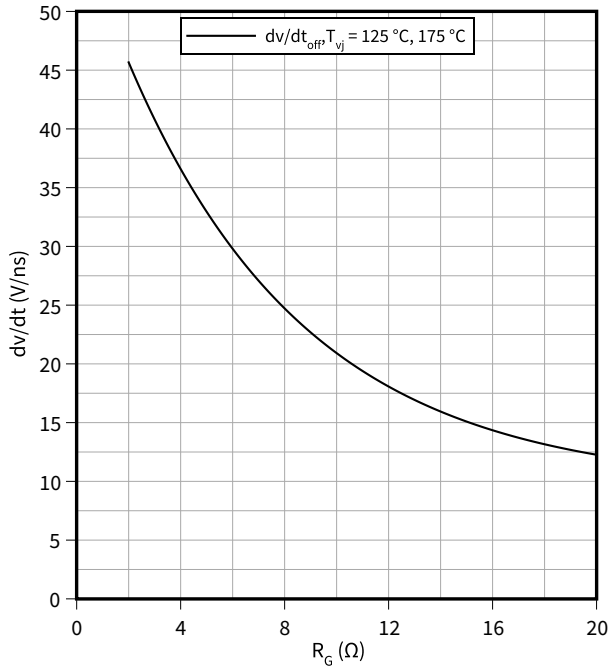


8 Characteristics diagrams

Voltage slope (typical), MOSFET

$dv/dt = f(R_G)$

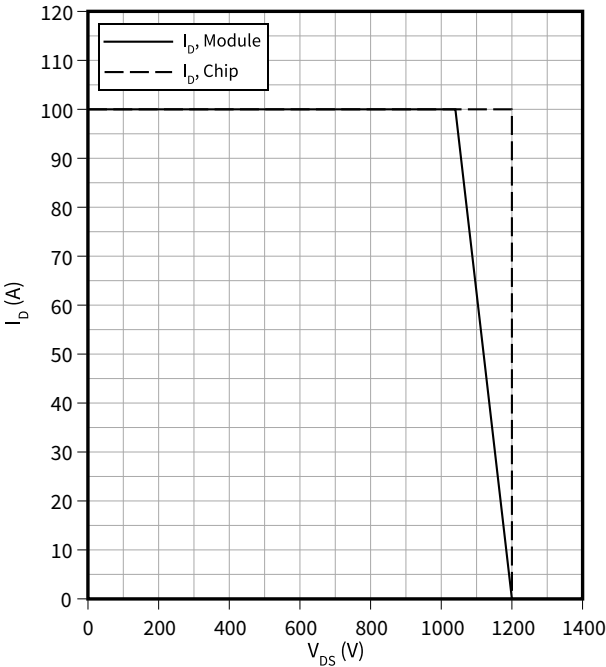
$V_{DD} = 600\text{ V}$, $I_D = 50\text{ A}$, $V_{GS} = -3/18\text{ V}$



Reverse bias safe operating area (RBSOA), MOSFET

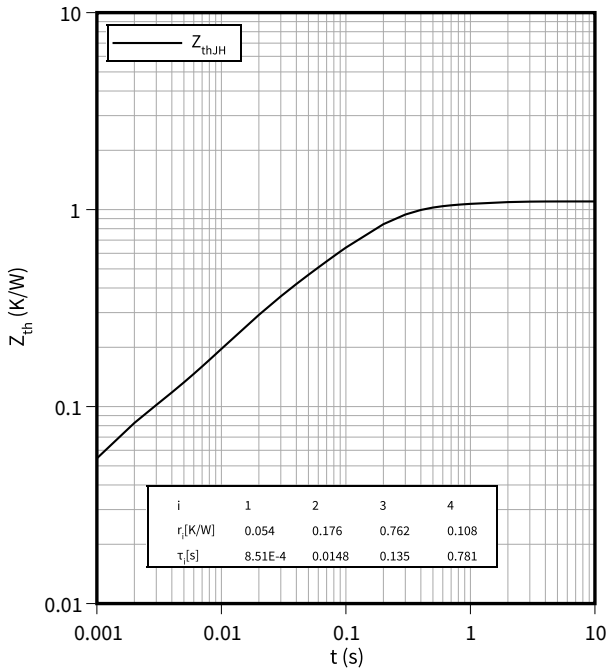
$I_D = f(V_{DS})$

$R_{Goff} = 2\ \Omega$, $T_{vj} = 175\ ^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



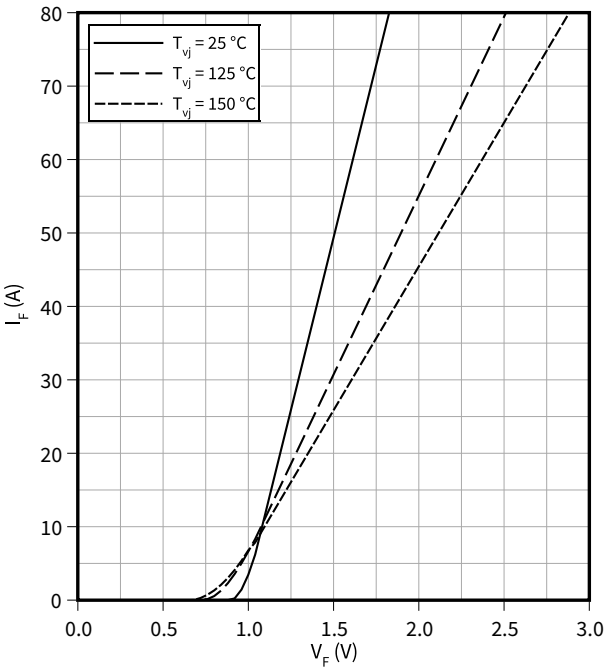
Transient thermal impedance, MOSFET

$Z_{th} = f(t)$



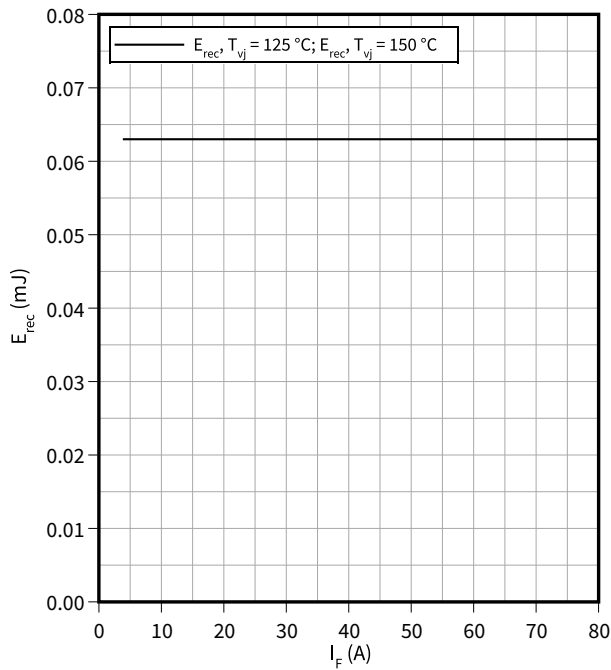
Forward characteristic (typical), Diode, Boost

$I_F = f(V_F)$



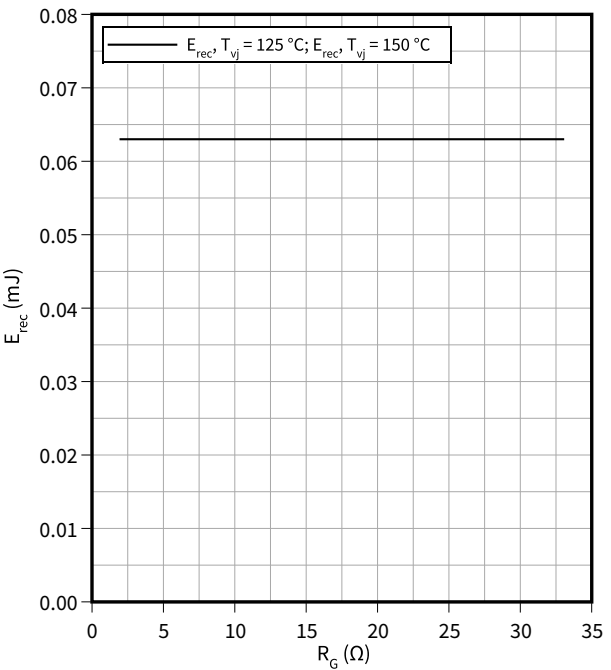
Switching losses (typical), Diode, Boost

$E_{rec} = f(I_F)$
 $R_{Gon} = 3.3 \Omega, V_{CC} = 600 V$



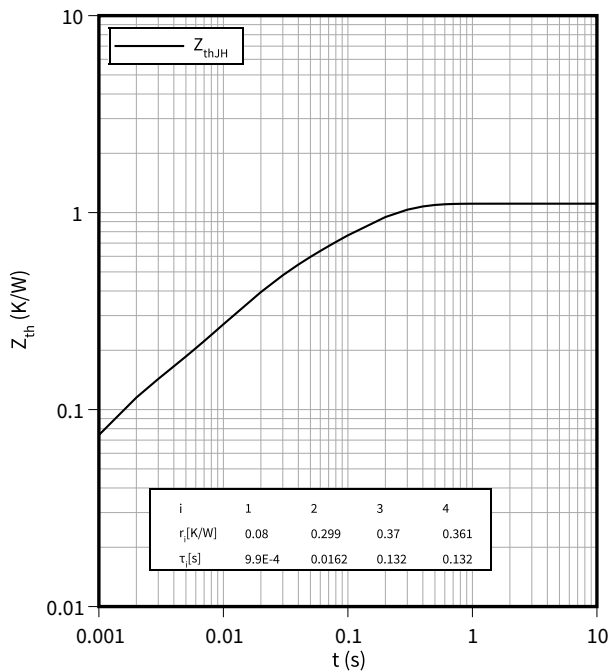
Switching losses (typical), Diode, Boost

$E_{rec} = f(R_G)$
 $I_F = 40 A, V_{CC} = 600 V$



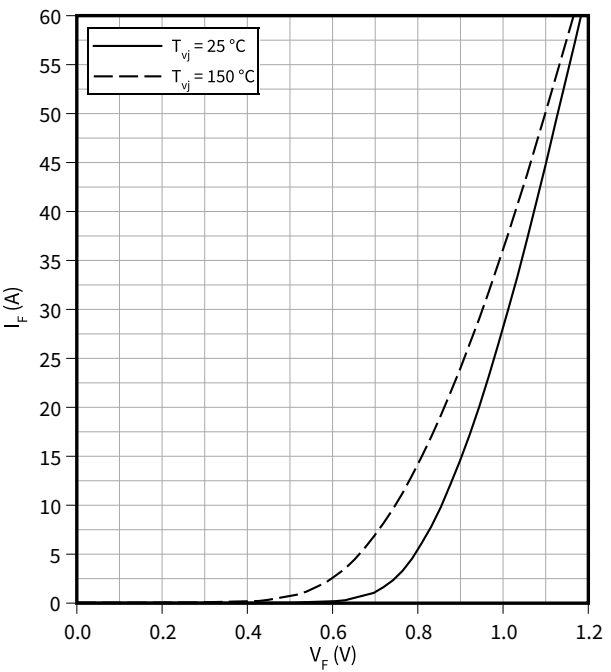
Transient thermal impedance, Diode, Boost

$Z_{th} = f(t)$



Forward characteristic (typical), Bypass-diode

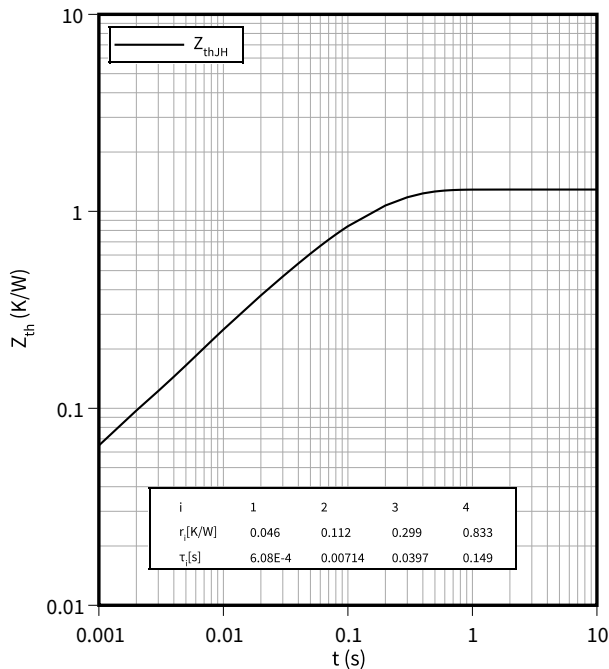
$I_F = f(V_F)$



8 Characteristics diagrams

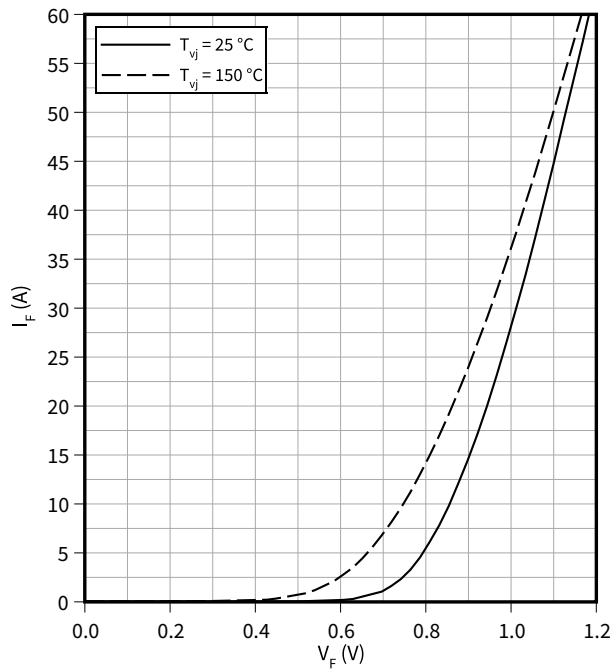
Transient thermal impedance, Bypass-diode

$Z_{th} = f(t)$



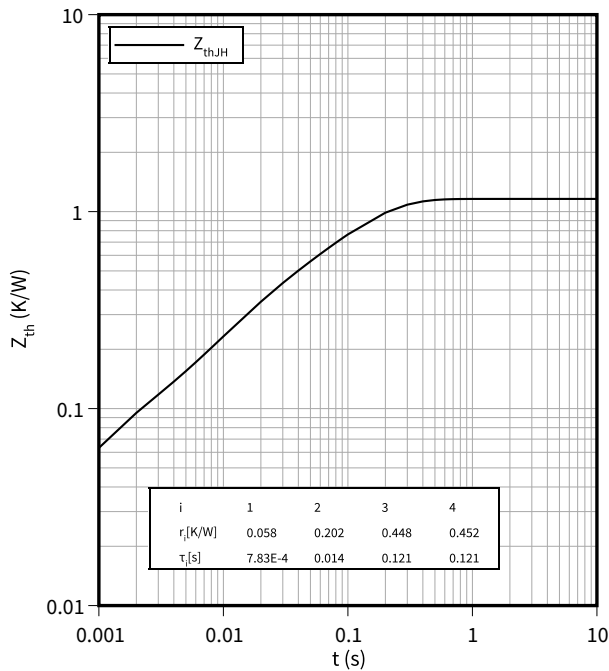
Forward characteristic (typical), Inverse-polarity protection diode

$I_F = f(V_F)$



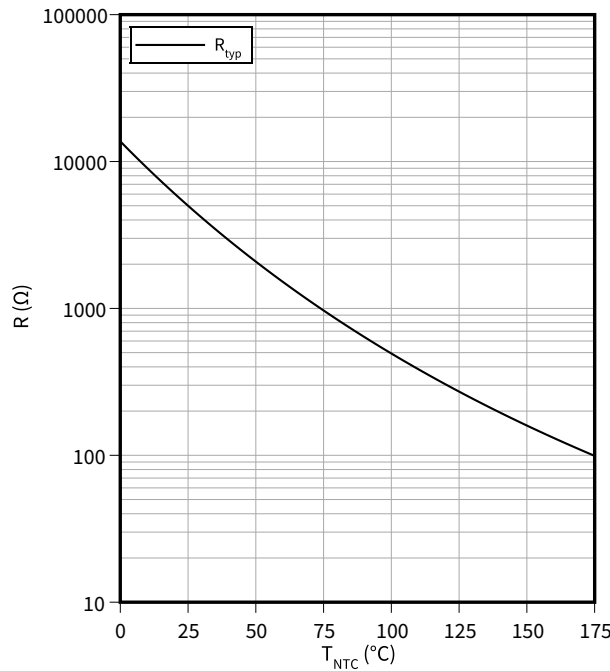
Transient thermal impedance, Inverse-polarity protection diode

$Z_{th} = f(t)$



Temperature characteristic (typical), NTC-Thermistor

$R = f(T_{NTC})$



9 Circuit diagram

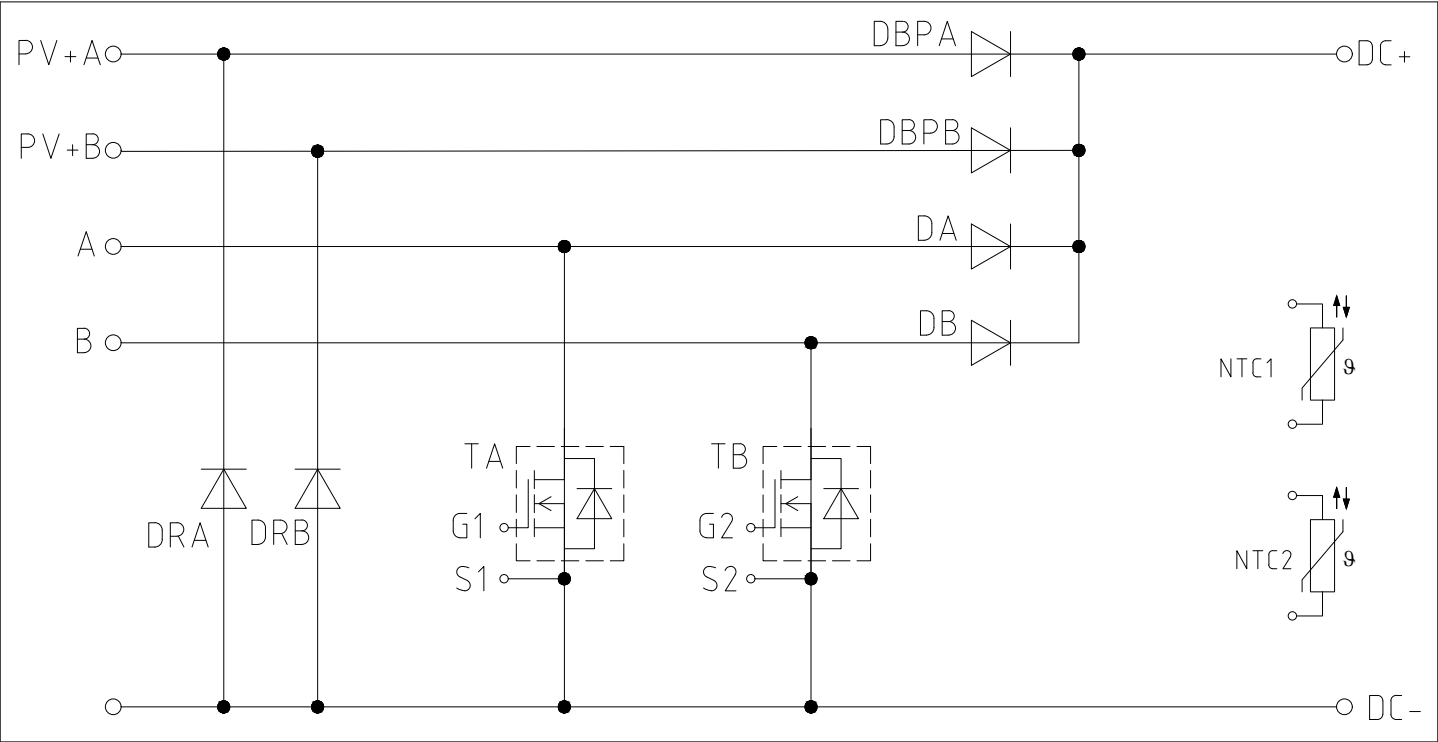


Figure 1

10

Figure 2

11 Module label code

Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	<i>Content</i>	<i>Digit</i>	<i>Example</i>
	Module serial number	1 – 5	71549
	Module material number	6 - 11	142846
	Production order number	12 - 19	55054991
	Date code (production year)	20 – 21	15
	Date code (production week)	22 – 23	30
Example			
	 71549142846550549911530	 71549142846550549911530	

Figure 3

Revision history

Document version	Date of release	Description of changes
0.10	2022-11-21	Initial version

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2022-11-21

Published by

Infineon Technologies AG
81726 Munich, Germany

© 2022 Infineon Technologies AG
All Rights Reserved.

Do you have a question about any aspect of this document?

Email: erratum@infineon.com

Document reference
IFX-ABE635-001

Important notice

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenhheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Warnings

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.